Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
-	10/743,388	TAKAGI ET AL.	
ľ	Examiner	Art Unit	
	CongVan Tran	2617	

	SEARCHED				
Class	Subclass	Date	Examiner		
455	558 557 517 412.1 550.1	6/27/2006	СТ		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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